

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination SAGAWA ET AL.	
		Examiner Amy E. Juedes, Ph.D.	Art Unit 1644	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,198,423	03-1993	Taguchi et al.	514/12
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Nunclon product information, VWRLabshop, page 1.
		Ostergaard et al., 1995, Eur. J. Immunol. Vol 25: 252-256.
	V	Pollok et al., 1998, J. Virol. Vol. 72: 4882-4892.
		Chen et al., 1994, J. Immunol. Vol 153: 3630-3638.
	W	Yoneda et al., 1995, Exp. Cell. Res. Vol 217: 169-179.
		Rostagno et al., 1999, Biochem. J. Vol 338: 375-386.
	X	Kornblihtt et al., 1996, FASEB J. Vol. 10: 248-257

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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